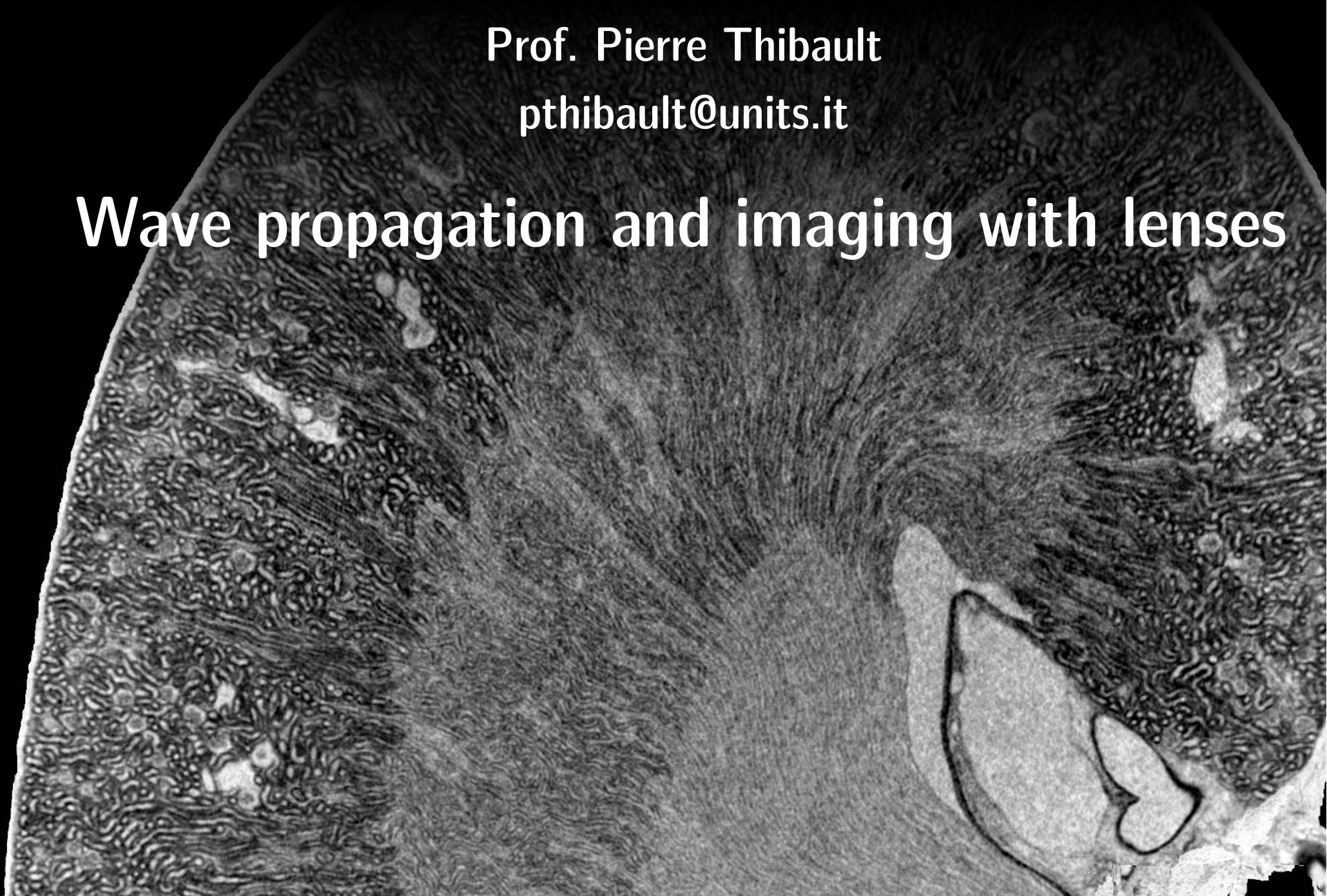


Image Processing for Physicists

Prof. Pierre Thibault

pthibault@units.it

Wave propagation and imaging with lenses



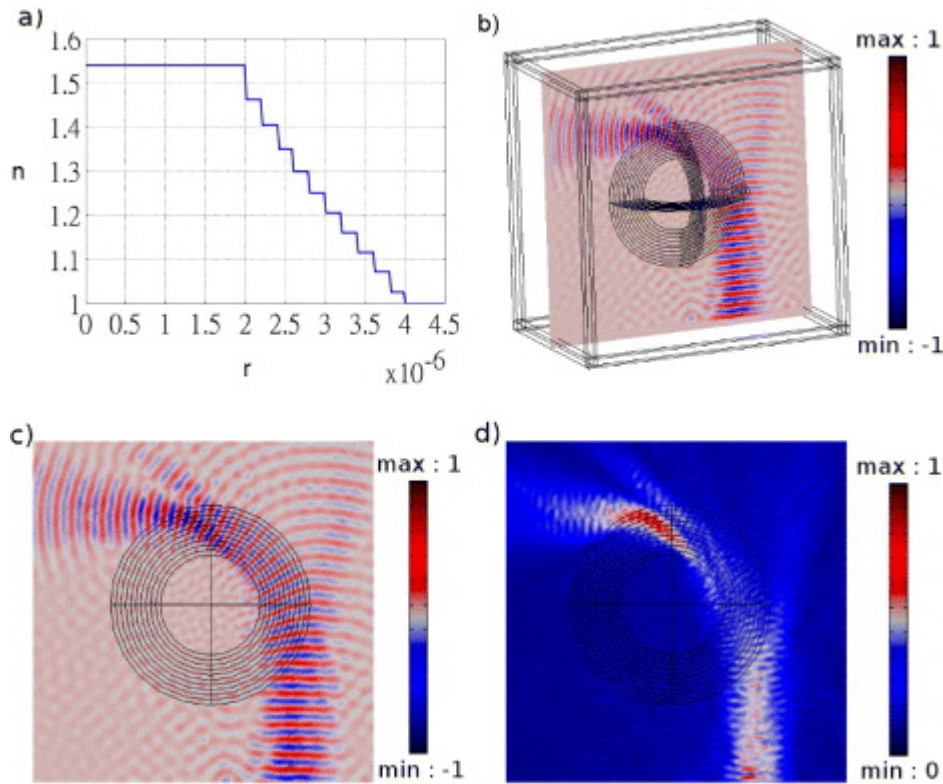
Overview

- Propagation modelization
- Wave propagation:
 - Near-field regime
 - Far-field regime

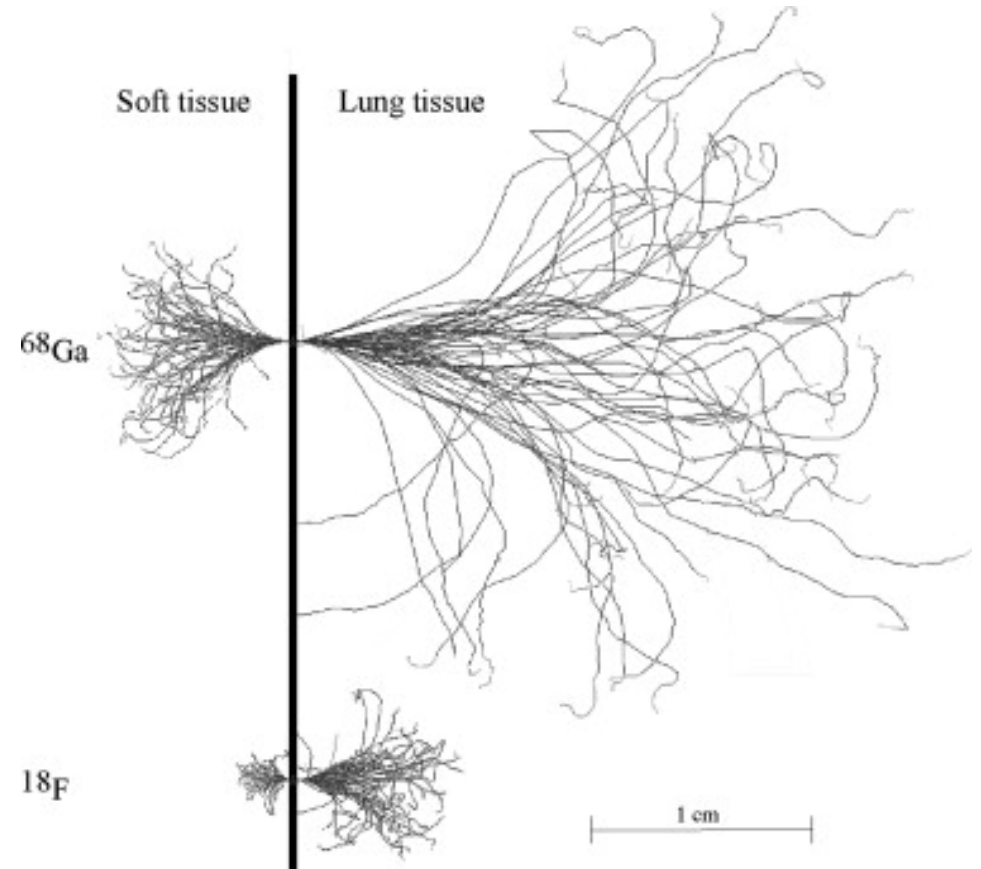
Propagation modeling

- Motivations:

1. Validation



Finite element simulation of an electromagnetic field in a dielectric



Monte Carlo simulation of positrons trajectories resulting from ^{68}Ga and ^{18}F decay.

sources: T.M. Chang *et al.* New J. Phys. (2012)
A. Sanchez-Crespo, Appl. Rad. Isotopes (2012)

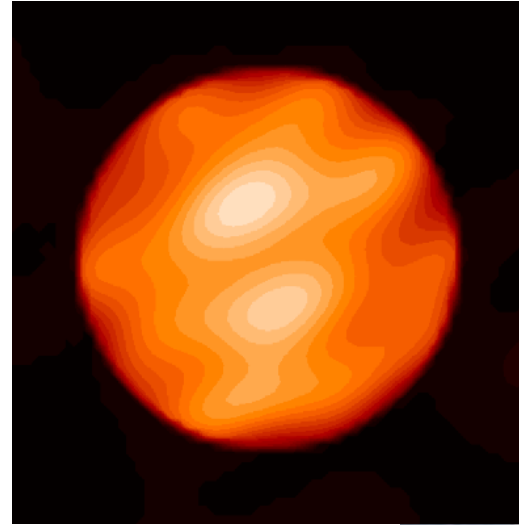
Propagation modeling

- Motivations:

2. Inversion



Image reconstruction from sound wave propagation (ultrasonography)



The surface of Betelgeuse reconstructed from interferometric data (IOTA)



sources: wikipedia

Haubois *et al.* *Astronom. & Astrophys.* (2009)

Propagation modeling

- Particles
 - Model particle tracks (rays) through different media
 - Model may include: refraction, force fields, particle decay and interactions
 - Not included: diffraction
- Wave
 - Model the interaction of a field with a medium
 - Can be very complicated → approximations are needed

Propagation modeling

Starting point: Helmholtz equation

- for EM field: neglect polarization (scalar wave approximation) *comes from Maxwell's equations*
- for electron wave, assume high energy electrons *↳ comes from Schrödinger*

result: Helmholtz:

$$\nabla^2 \psi - \frac{n^2}{c^2} \frac{\partial^2 \psi}{\partial t^2} = 0$$

consider solutions of the form $\psi(\vec{r}, t) = \psi(\vec{r}) e^{i\omega t}$

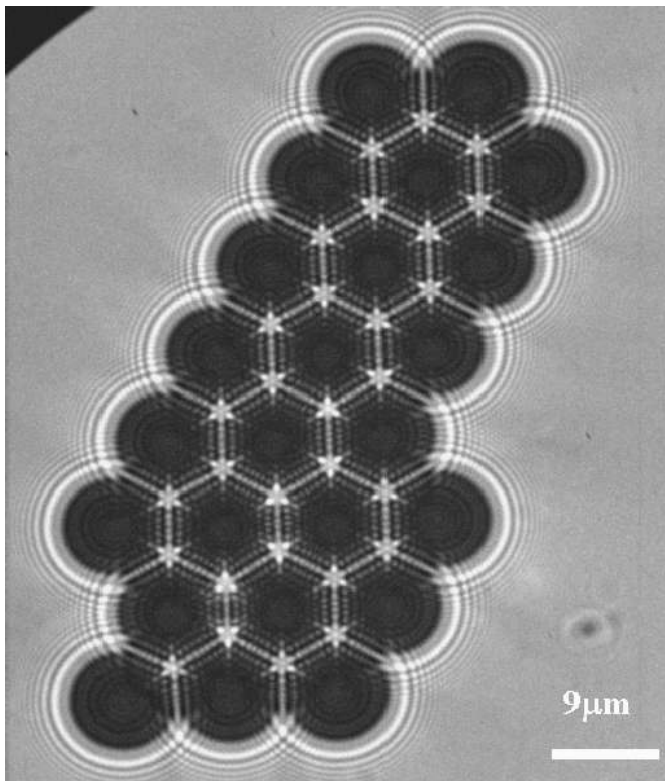
*fixed frequency
(monochromatic)*

$$k = \frac{2\pi}{\lambda} \text{ (wavenumber)} \quad \nabla^2 \psi + k^2 n^2 \psi = 0 \quad k^2 = \frac{\omega^2}{c^2}$$

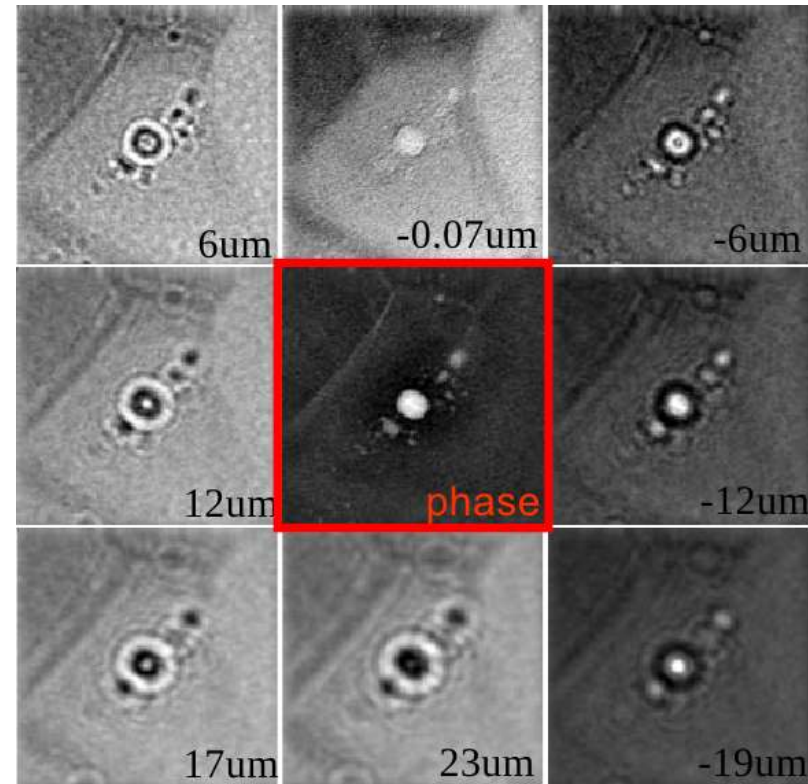
Propagation modeling

- Useful to:
 - better understand optical systems
 - understand diffraction, holography, phase contrast, interferometry, ...

X-ray hologram



TEM through-focus series



sources: Mayo *et al.* Opt. Express (2003)
<http://www.christophtkoch.com/Vorlesung/>

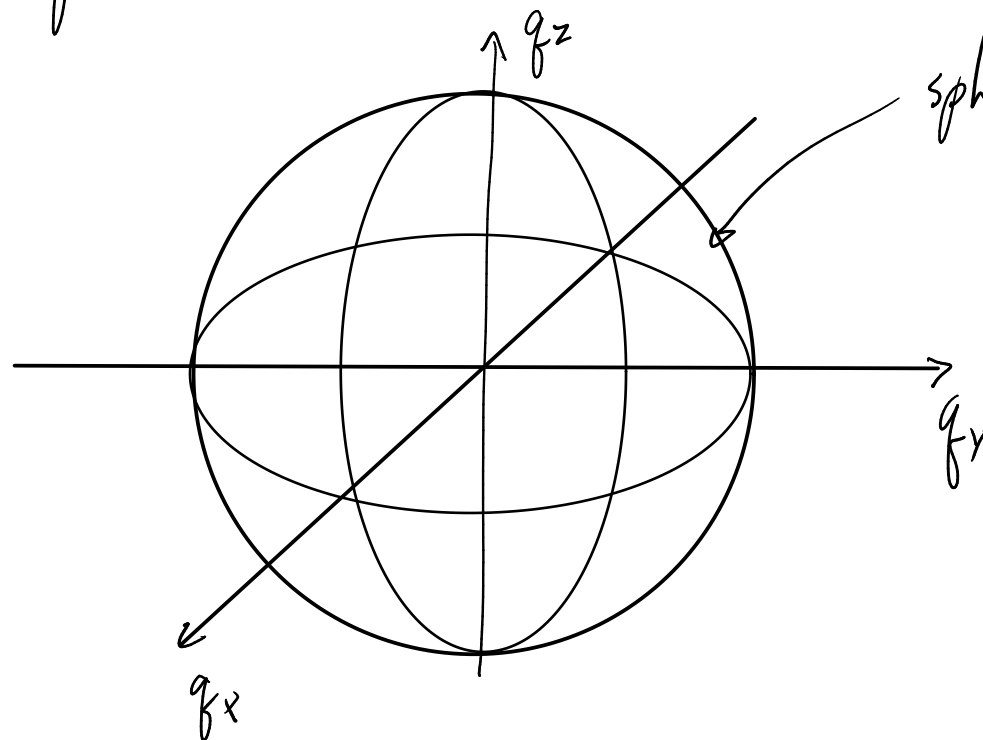
The physics of propagation

Free space propagation: $n=1$

General solution: superposition of plane waves

$$\psi(\vec{r}) = \sum_{\vec{q}} A_{\vec{q}} e^{i\vec{q} \cdot \vec{r}} \quad \begin{array}{l} \text{sum is over } \vec{q} \text{ such} \\ \text{that } q^2 = k^2 \end{array}$$

$$q_x^2 + q_y^2 + q_z^2 = k^2 \quad \text{surface of a sphere}$$



"Ewald sphere"

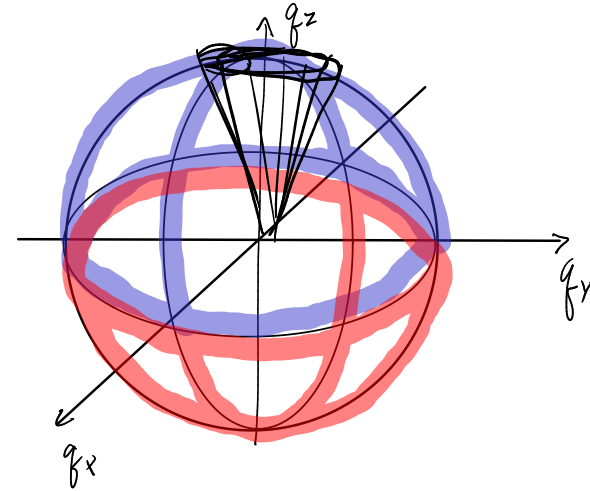
The physics of propagation

Angular spectrum representation

$$q_z = \begin{matrix} + \\ - \end{matrix} \sqrt{k^2 - q_x^2 - q_y^2}$$

$$\psi(\vec{r}) = \sum_{q_x q_y} A_{q_x q_y}^+ e^{i(q_x x + q_y y + \sqrt{k^2 - q_x^2 - q_y^2} z)}$$

~~$$+ \sum_{q_x q_y} A_{q_x q_y}^- e^{i(q_x x + q_y y - \sqrt{k^2 - q_x^2 - q_y^2} z)}$$~~



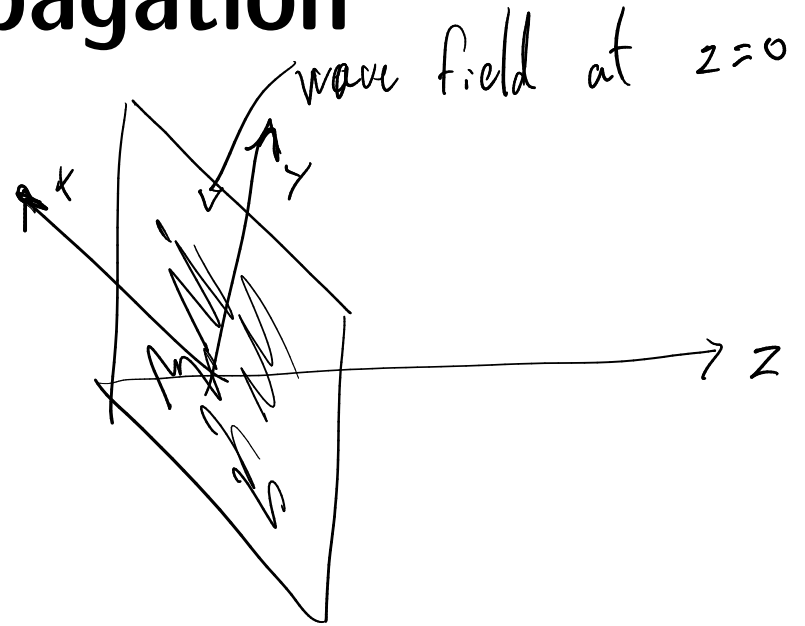
we consider only propagation along positive z

$$\psi(x, y, z) = \underbrace{\sum_{q_x q_y} A_{q_x q_y} e^{i(q_x x + q_y y)}}_{\text{2D Fourier transform!}} e^{i\sqrt{k^2 - q_x^2 - q_y^2} z}$$

Forward propagation

Plane $z=0$:

$$\psi(x, y, z=0) = \sum_{q_x, q_y} A_{q_x, q_y} e^{i(q_x x + q_y y)}$$



$$A_{q_x, q_y} = \mathcal{F} \{ \psi(x, y, z=0) \}$$

Recipe: $\psi(\vec{r}_\perp; z) = \mathcal{F}^{-1} \left\{ \mathcal{F} \{ \psi(\vec{r}_\perp; z=0) \} \exp(i z \sqrt{k^2 - q_\perp^2}) \right\}$

$\swarrow (x, y)$ $\nwarrow (q_x, q_y)$

In Practice: $\psi(x, y, z) = \bar{\Psi}(x, y, z) e^{i k z}$

$$\bar{\Psi}(\vec{r}_\perp; z) = \mathcal{F}^{-1} \left\{ \mathcal{F} \{ \bar{\Psi}(\vec{r}_\perp; z=0) \} \exp(i z [\sqrt{k^2 - q_\perp^2} - k]) \right\}$$

Angular spectrum propagation method

Forward propagation

$$e^{2\pi i u x} \leftrightarrow e^{2\pi i k / N}$$

Discretization

Sampling: Δx : sampling pitch

Δu : Fourier-space sampling pitch

$$\Delta u = \frac{1}{N \Delta x}$$

$$x = n \Delta x$$

$$u = k \Delta u$$

$$u x = n k \Delta x \Delta u$$

$$\hookrightarrow \Delta x \Delta u = \frac{1}{N}$$

$$\Delta u = \frac{1}{N \Delta x}$$

$$q_x = 2\pi u = 2\pi k \Delta u$$

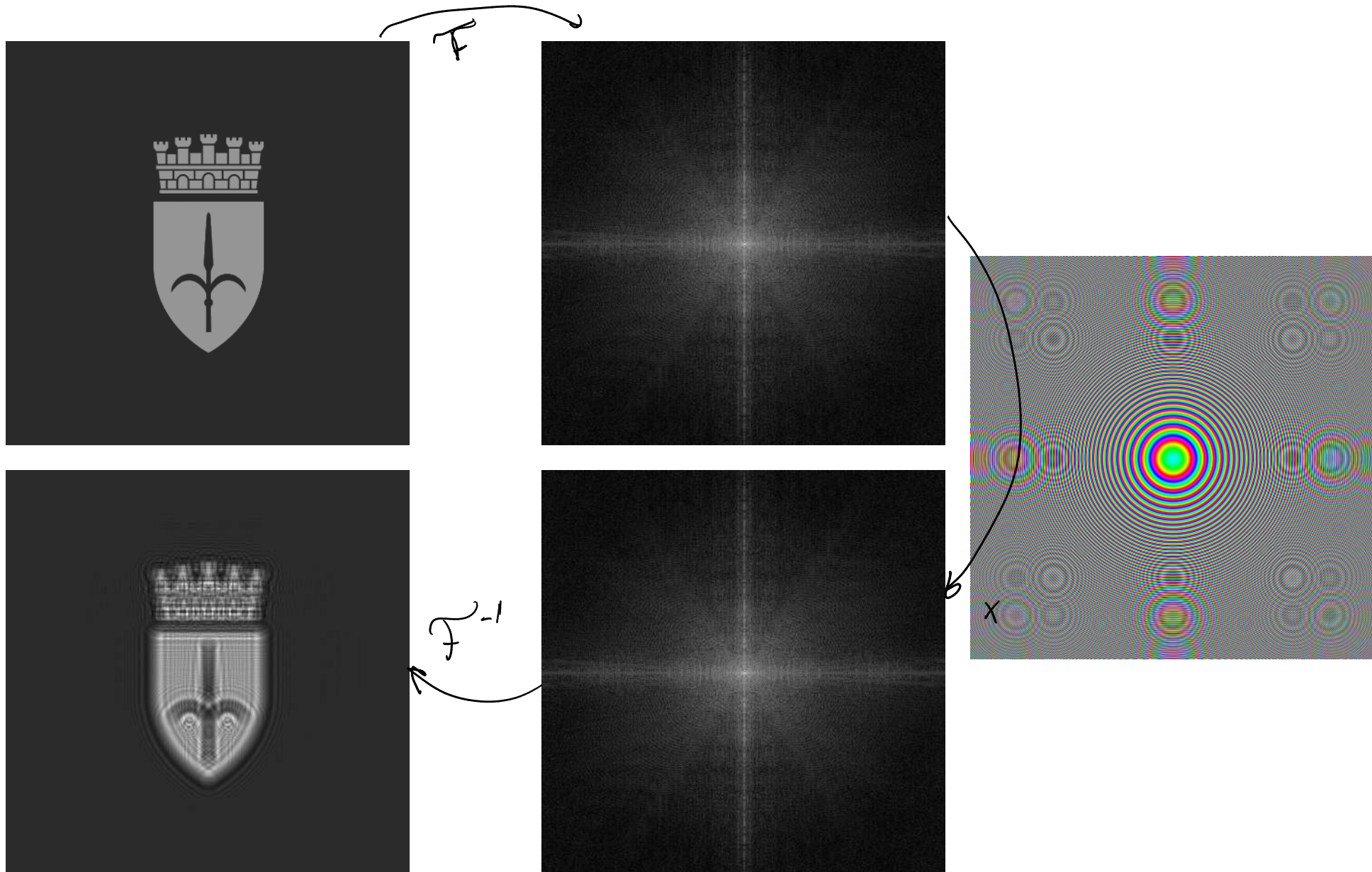
$$\sqrt{k^2 - q_x^2 - q_y^2} = \sqrt{\left(\frac{2\pi}{\lambda}\right)^2 - (2\pi u)^2 - (2\pi v)^2} = \frac{2\pi}{\lambda} \sqrt{1 - \lambda^2 u^2 - \lambda^2 v^2} \leftarrow$$

$$= \frac{2\pi}{\lambda} \sqrt{1 - \lambda^2 \Delta u^2 (k^2 + l^2)}$$

$$\exp\left(iz \left[\sqrt{k^2 - q_x^2 - q_y^2} - k\right]\right) = \exp\left[\frac{2\pi i z}{\lambda} \left[\sqrt{1 - \lambda^2 (u^2 + v^2)} - 1\right]\right]$$

Forward propagation

A numerical recipe



Near field, far field

Problem: as z increases, aliasing becomes a problem. There's a trick.

$$\frac{2\pi}{\lambda} \left[\sqrt{1 - \lambda^2 (u^2 + v^2)} - 1 \right] \approx \frac{2\pi}{\lambda} \left[1 - \frac{1}{2} \lambda^2 (u^2 + v^2) - 1 \right] \leftarrow \text{paraxial approximation}$$

$$= -\pi \lambda (u^2 + v^2) \quad (\text{small angle scattering})$$

$$\Psi(r_{\perp}; z) = \mathcal{F}^{-1} \left\{ \mathcal{F} \left\{ \Psi(r_{\perp}; z=0) \right\} \exp(-i\pi \lambda z (u^2 + v^2)) \right\}$$

observation: this has the form of a convolution!

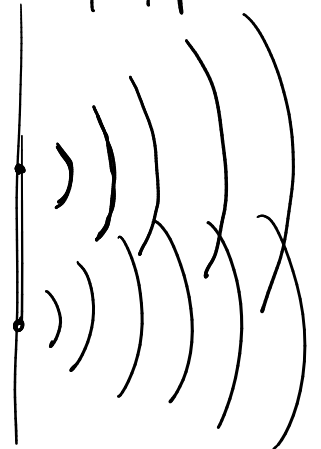
$$\Psi(r_{\perp}; z) = \Psi(r_{\perp}; z=0) * P_z(r_{\perp})$$

Fresnel-Huygens
integral

Huygens principle

$$P_z(r_{\perp}) = \mathcal{F}^{-1} \left\{ \exp(-i\pi \lambda z (u^2 + v^2)) \right\}$$

$$= -\frac{2\pi i}{\lambda z} \exp\left(\frac{i\pi r_{\perp}^2}{\lambda z}\right)$$



Near field, far field

$$\Psi(\vec{r}_2; z) = \frac{-2\pi i}{\lambda z} \int d^2 r' \Psi(\vec{r}'; z=0) \exp\left(\frac{i\pi(\vec{r} - \vec{r}')^2}{\lambda z}\right)$$

$$= \frac{-2\pi i}{\lambda z} \int d^2 r' \Psi(\vec{r}'; z=0) \exp\left[\frac{i\pi}{\lambda z} [r^2 + r'^2 - 2\vec{r} \cdot \vec{r}']\right]$$

can insert a lens here

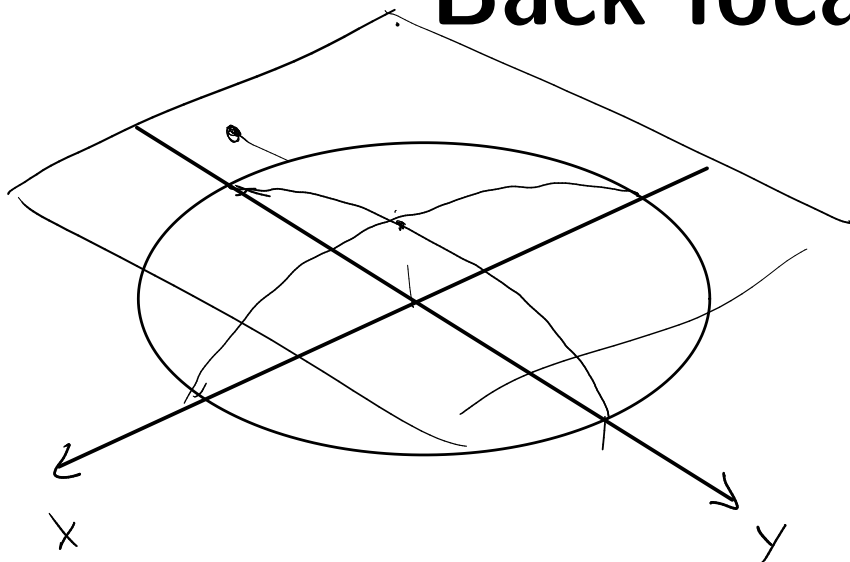
$$= \frac{-2\pi i}{\lambda z} \exp\left(\frac{i\pi r^2}{\lambda z}\right) \int d^2 r' \Psi(\vec{r}'; z=0) \exp\left(\frac{i\pi r'^2}{\lambda z}\right) \exp\left(-2\pi i \frac{\vec{r} \cdot \vec{r}'}{\lambda z}\right)$$

$$\Psi(\vec{r}_\perp; z) = \frac{-2\pi i}{\lambda z} \exp\left(\frac{i\pi r^2}{\lambda z}\right) \mathcal{F}\left\{\Psi(\vec{r}; z=0) \exp\left(\frac{i\pi r^2}{\lambda z}\right)\right\} \left(\vec{u} = \frac{\vec{r}}{\lambda z}\right)$$

observation: as $z \rightarrow \infty$ $|\Psi(\vec{r}; z \rightarrow \infty)|^2 \propto \left|\mathcal{F}\left\{\Psi(\vec{r}; z=0)\right\}\right|^2 \left(\vec{u} = \frac{\vec{r}}{\lambda z}\right)$

Back focal plane of a lens

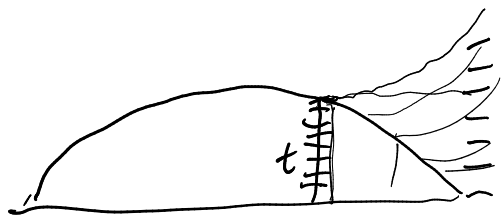
2D radial coordinate



* thickness profile $t(r) = t_0 - \alpha r^2$

* phase $\phi(\vec{r}_\perp) = \frac{2\pi t(\vec{r}_\perp)}{\lambda} (n-1)$
 $= k(n-1)t = -\frac{2\pi\alpha}{\lambda} (n-1)r^2$

* focal length $(n-1)\alpha = \frac{1}{2f} \Rightarrow \phi = -\frac{\pi\alpha r^2}{\lambda f}$



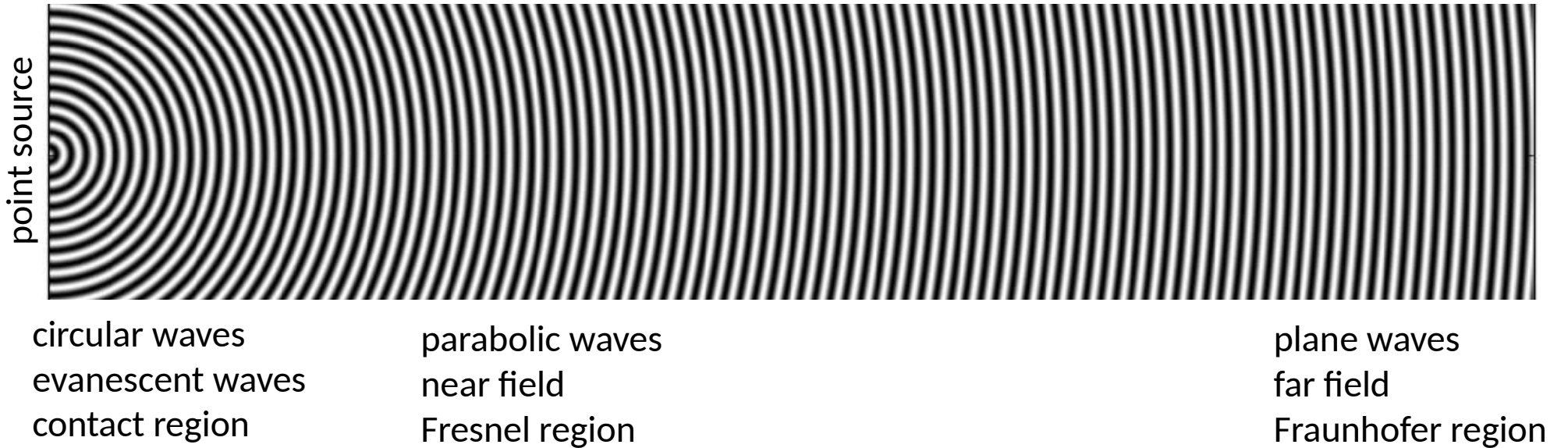
effect of a lens: $\bar{\Psi}(r_\perp; z=0) \rightarrow \bar{\Psi} \cdot \exp\left(\frac{-i\pi r^2}{\lambda f}\right)$

$$\bar{\Psi}(\vec{r}_\perp; z) = \frac{-2\pi i}{\lambda z} \exp\left(\frac{i\pi r^2}{\lambda z}\right) \int \left\{ \bar{\Psi}(\vec{r}'_\perp; z=0) \exp\left(\frac{i\pi r'^2}{\lambda} \left(\frac{1}{z} - \frac{1}{f}\right)\right) \right\} \left(\vec{u} = \frac{\vec{r}}{\lambda z}\right)$$

special case: $z = f$: $\bar{\Psi}(\vec{r}_\perp; z=f) = () \cdot \text{F.T. of } \bar{\Psi}(\vec{r}_\perp; z=0)$

\Rightarrow a converging lens acts as a Fourier transform operator!

Plane waves, point sources



Why optical elements?



with objective lens

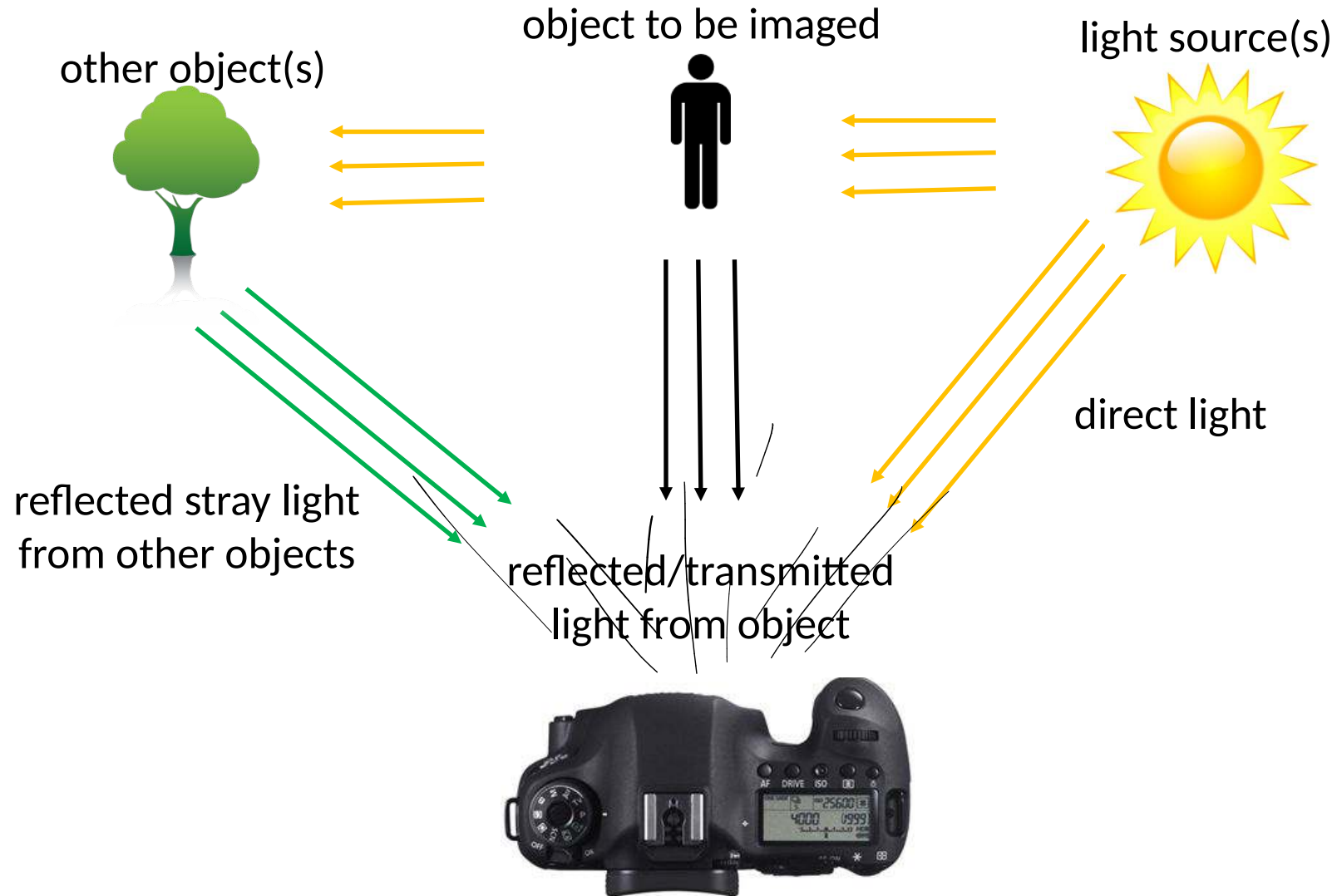


without objective lens



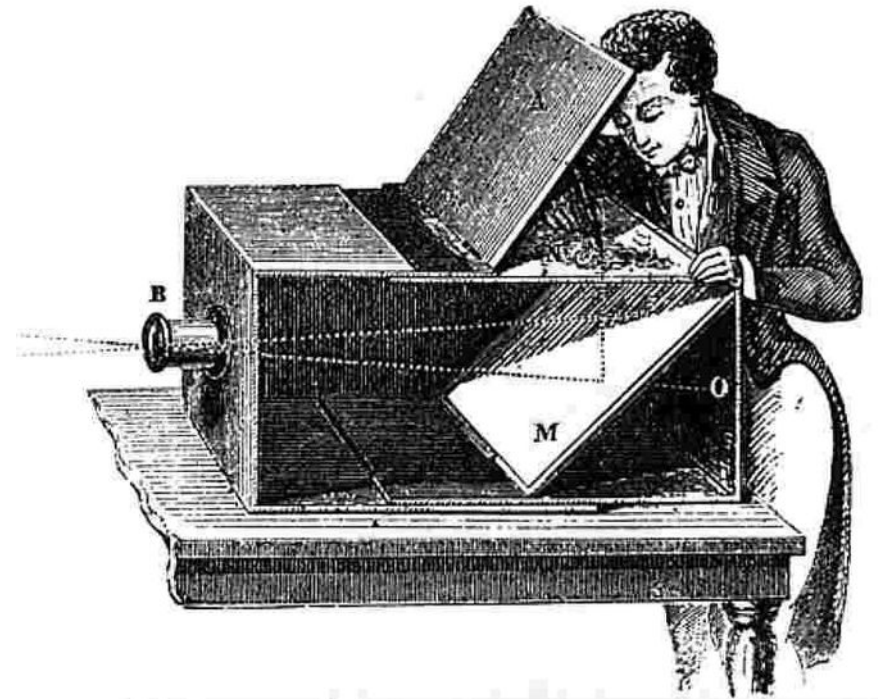
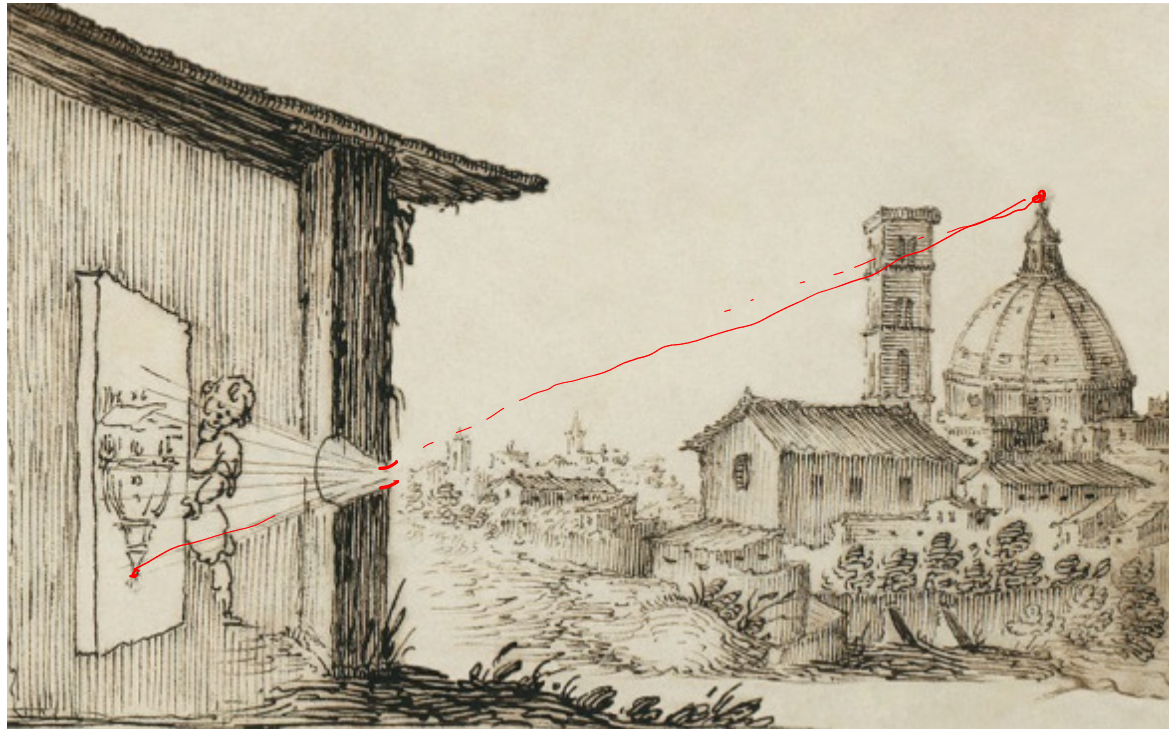
Why optical elements?

- Information from many sources overlaps in detector plane
- Need models to understand image forming systems



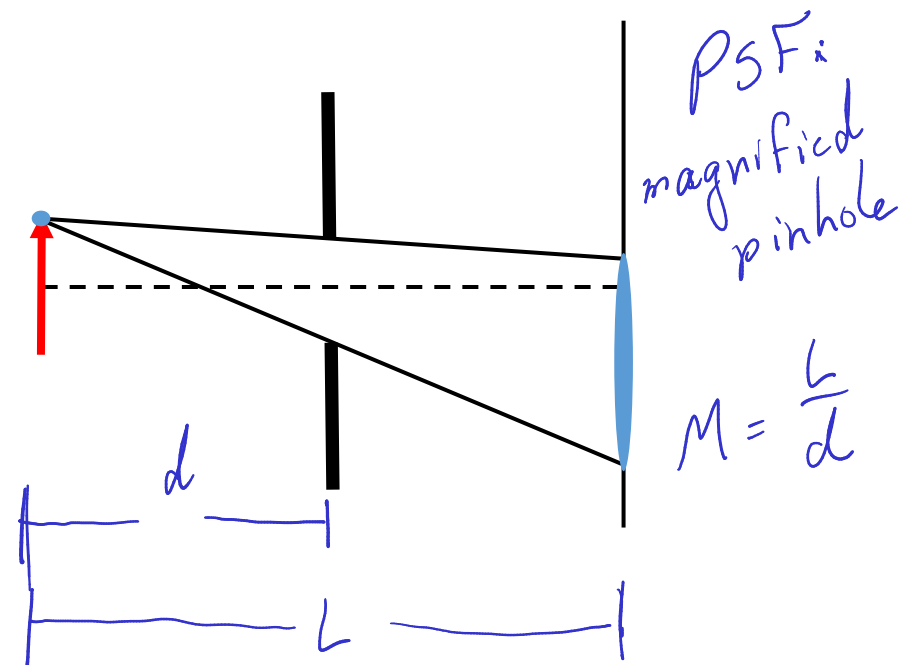
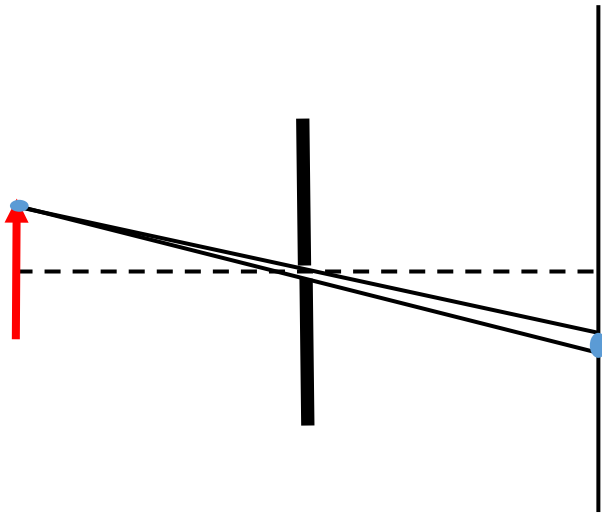
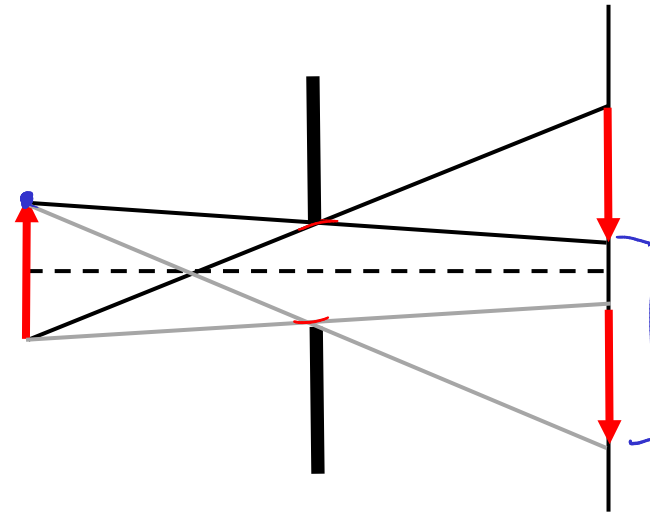
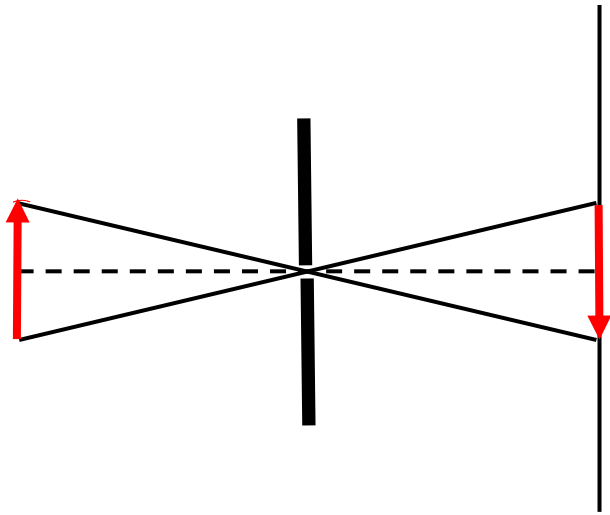
Pinhole camera model

camera obscura



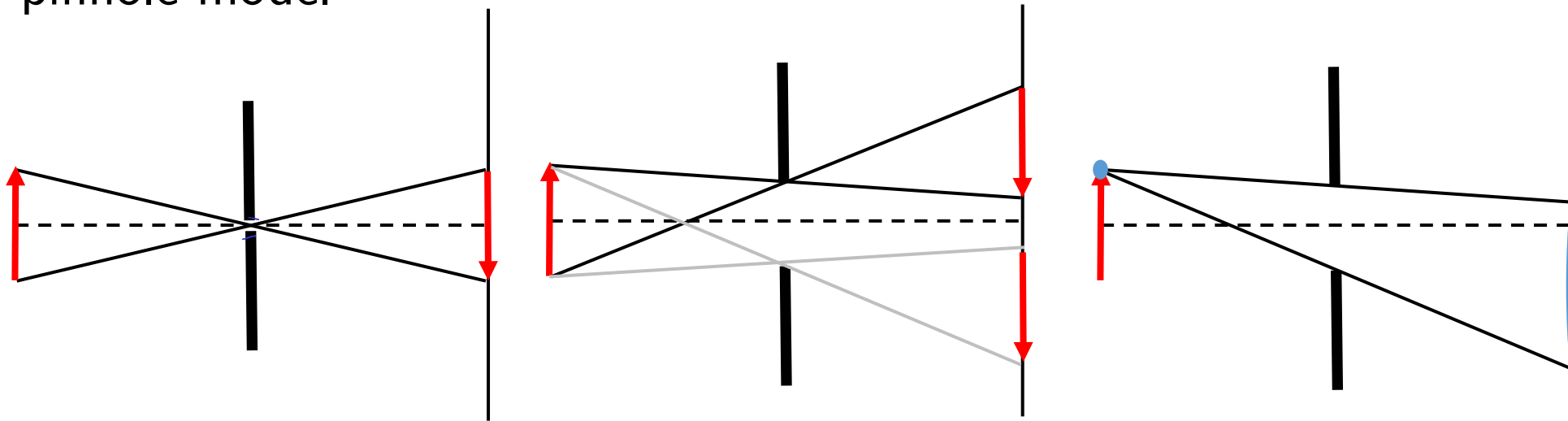
Pinhole camera model

PSF determined by aperture width



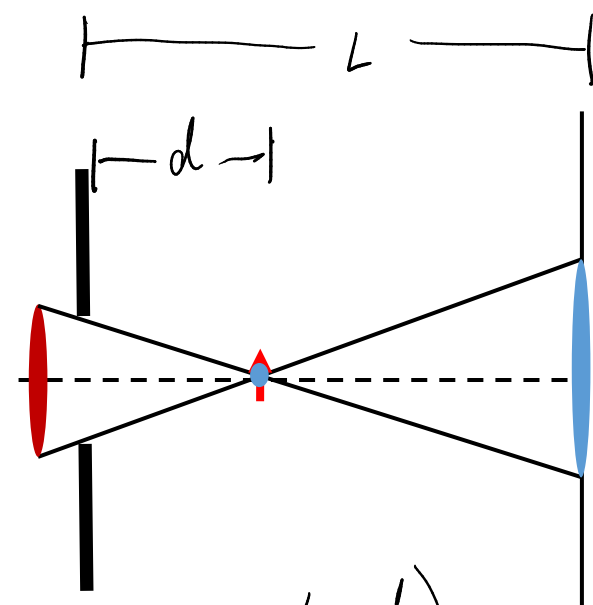
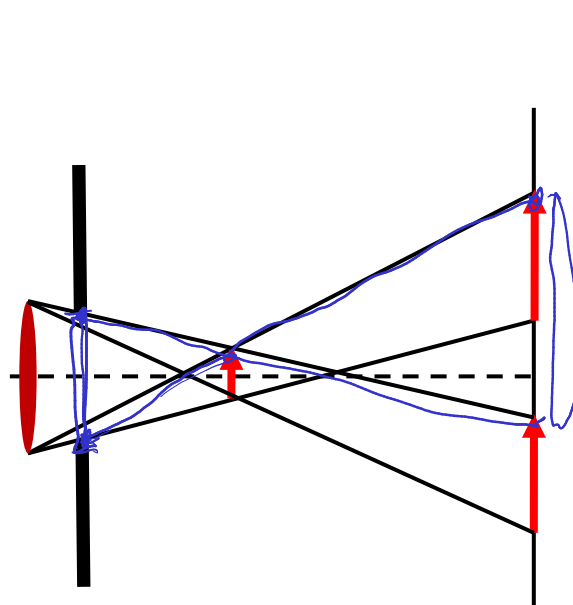
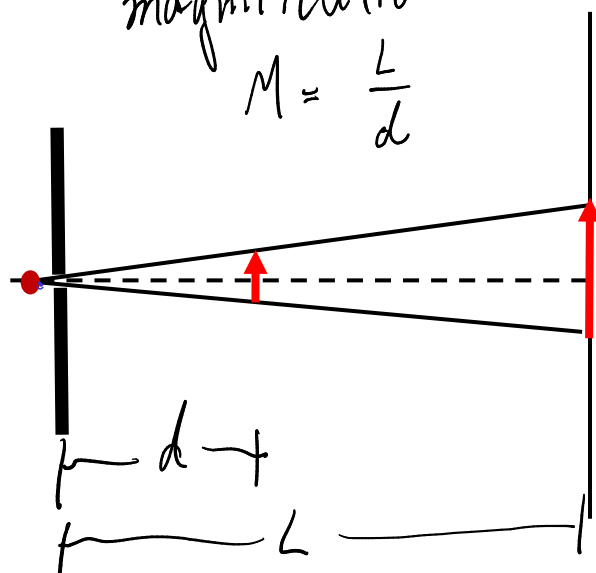
Projection model

pinhole model



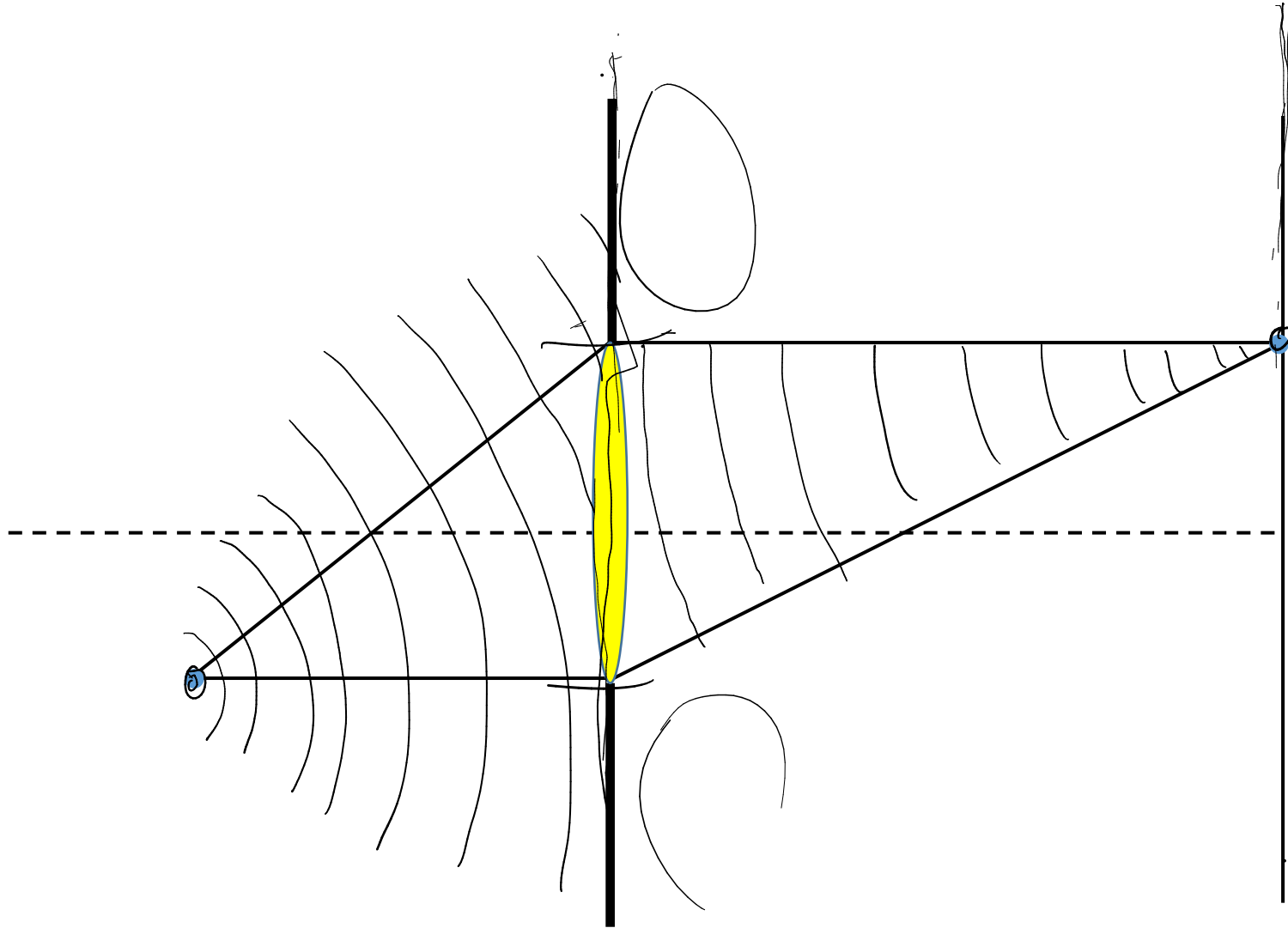
projection model

magnification
 $M = \frac{L}{d}$



PSF width = source size $\times \left(\frac{L+d}{d} \right)$

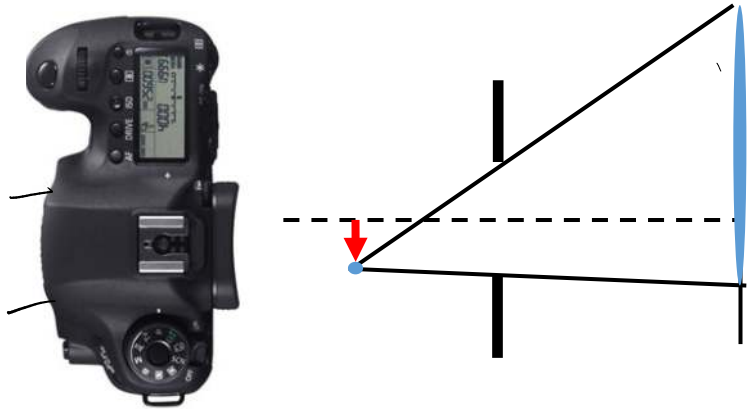
Lens camera model



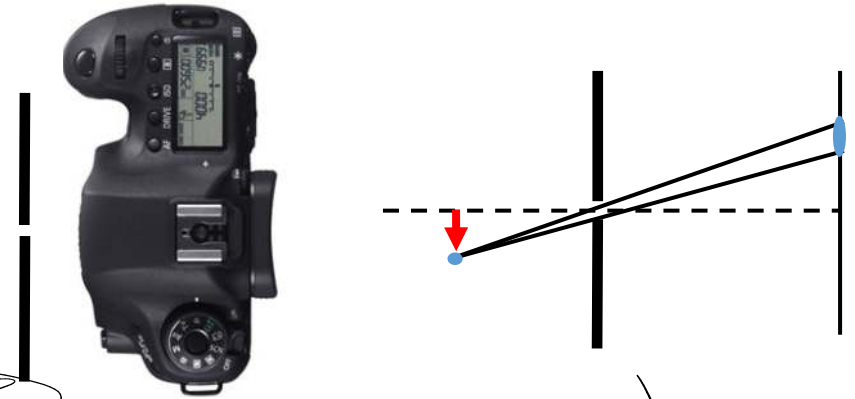
Result similar to small pinhole but without compromise on intensity

Lens camera model

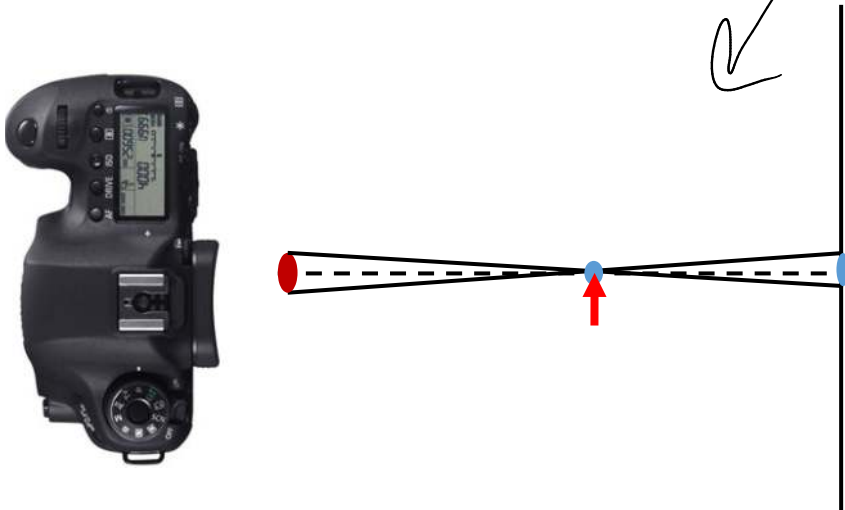
lensless model



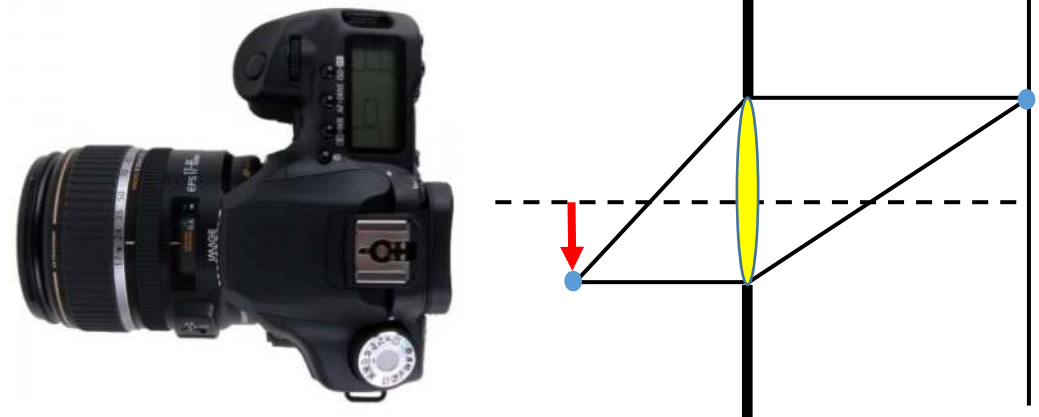
pinhole camera model



projection model



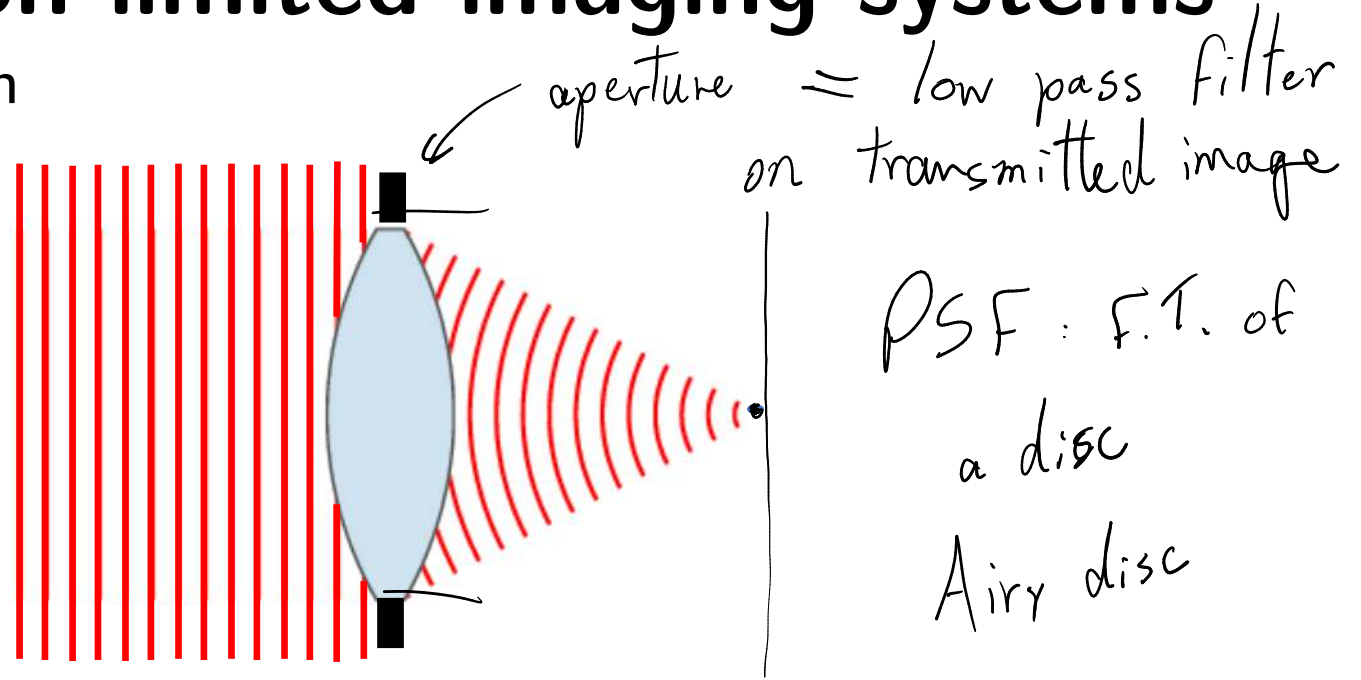
lens camera model



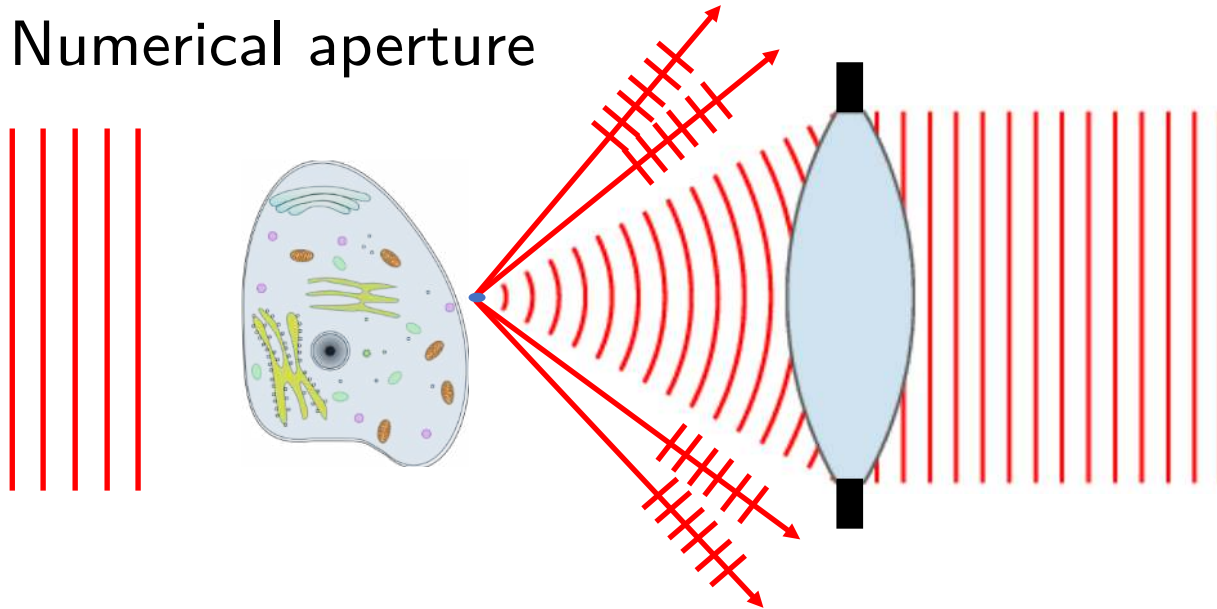
Diffraction-limited imaging systems

- Rayleigh criterion

• point source at infinity



- Numerical aperture



Inverse Fourier transform of disc of radius u_{\max} :

$$\frac{J_1(2\pi r u_{\max})}{r u_{\max}} \quad J_1: \text{First Bessel function}$$

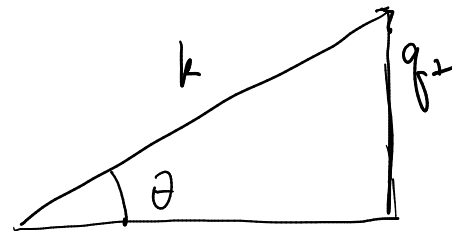
Rayleigh criterion: resolution = distance to the first minimum from the origin:

$$u_{\max} = \frac{f_{\max}}{2\pi}$$

$$J_1(2\pi r_{\min} u_{\max}) = 0$$

$$f_{\max} = k \sin \theta$$

$$3.83 = 2\pi r_{\min} u_{\max} \rightarrow r_{\min} = \frac{3.83}{2\pi u_{\max}}$$

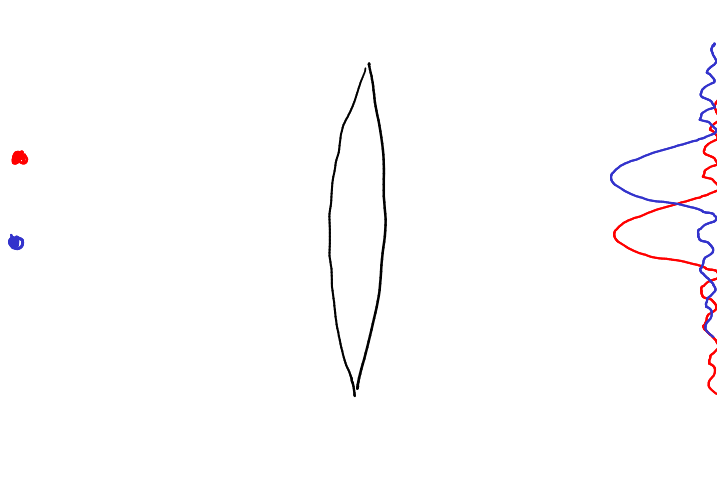


$$r_{\min} = \frac{3.83}{2\pi} \frac{2\pi}{k \sin \theta} = \frac{3.83}{2\pi} \frac{\lambda}{\sin \theta}$$

$2 \sin \theta = \text{NA}$
"numerical aperture"

$$r_{\min} = \frac{1.22 \lambda}{2 \sin \theta}$$

Coherent vs incoherent imaging system



two images of point sources

1) if the two sources are perfectly coherent, then interference occurs:

$$I = |\psi_1 + \psi_2|^2$$

$$\hookrightarrow I = |\text{PSF}_{\text{coh}} * \psi|^2$$

2) if the two sources do not interfere (incoherent)

$$I = |\psi_1| + |\psi_2|^2$$

In general:

$$I = \text{PSF}_{\text{inc}} * |\psi|^2$$

$$|\psi_1 + \psi_2|^2 = |\psi_1|^2 + |\psi_2|^2$$

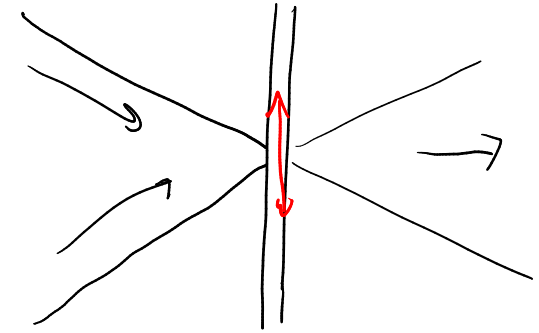
$$+ 2 \text{Re} \{ \psi_1^* \psi_2 \}$$

= 0 if incoherent

Scanning systems

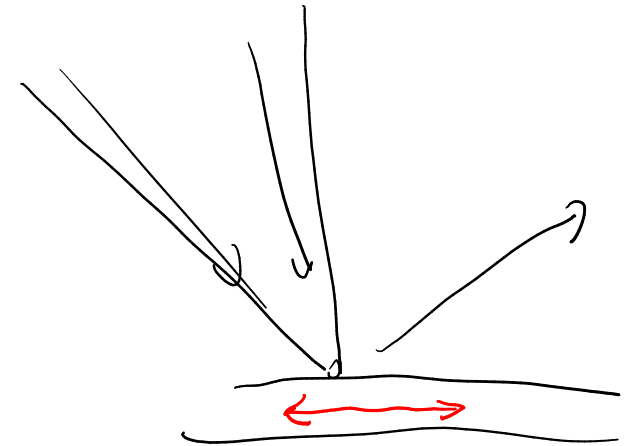
Transmission

- **Scanning Transmission Electron Microscopy**
- **Scanning Transmission X-ray Microscopy**
- ...



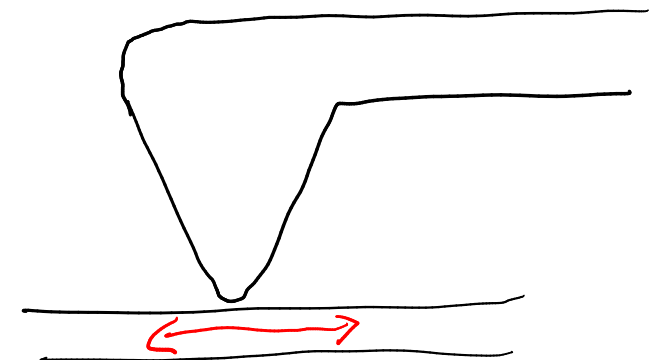
Indirect (reflection, scattering, fluorescence, ...)

- **Laser Scanning Confocal Microscopy**
- **Scanning Electron Microscopy**
- **X-ray Fluorescence Microscopy**
- **PhotoEmission Electron Microscopy**
- ...



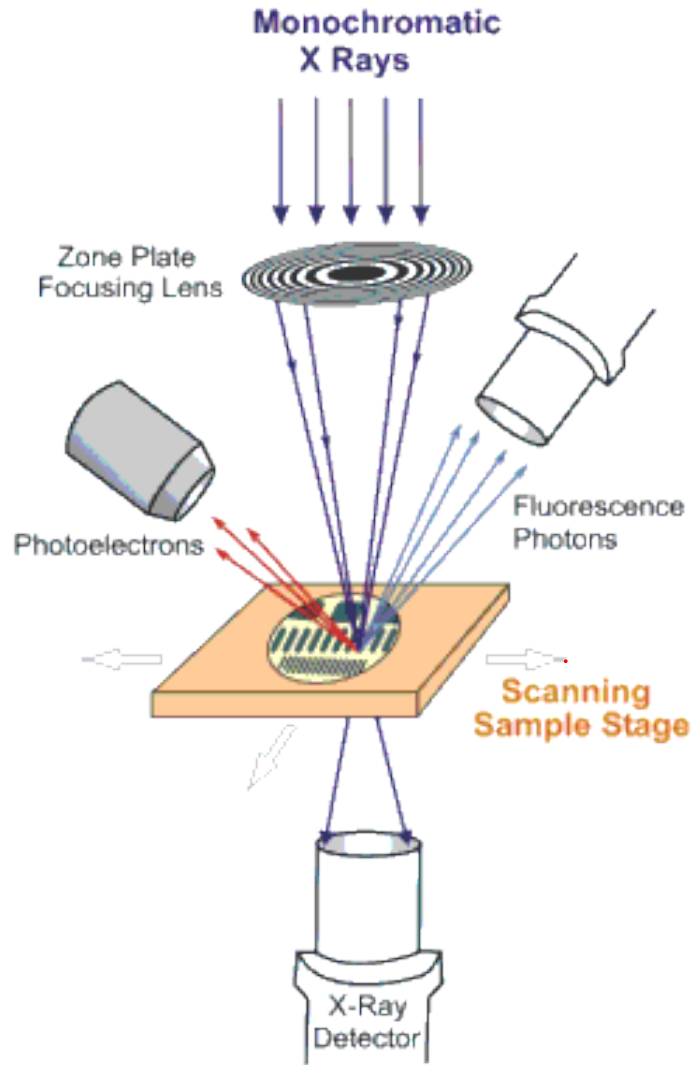
Physical probe

- **Atomic Force Microscopy**
- **Scanning Tunneling Microscopy**
- ...

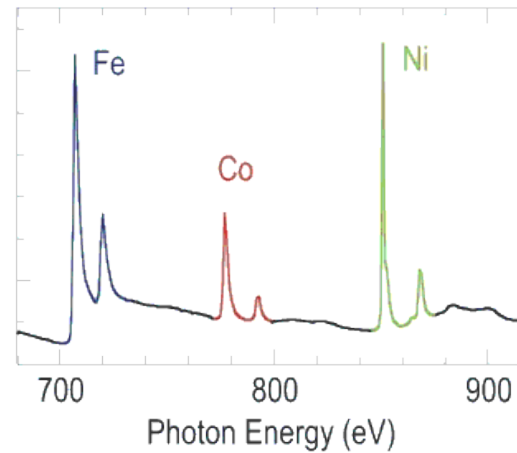


Scanning transmission X-ray microscopy

Scanning Transmission X-ray Microscopy
STXM

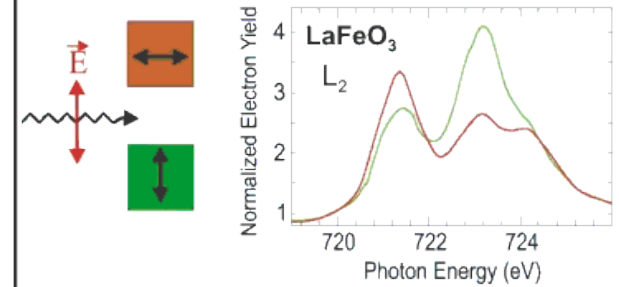


Tune x-ray **energy**
for elemental specificity

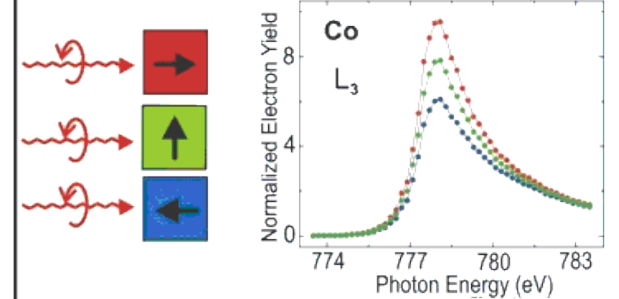


Tune x-ray **polarization**
for magnetic specificity

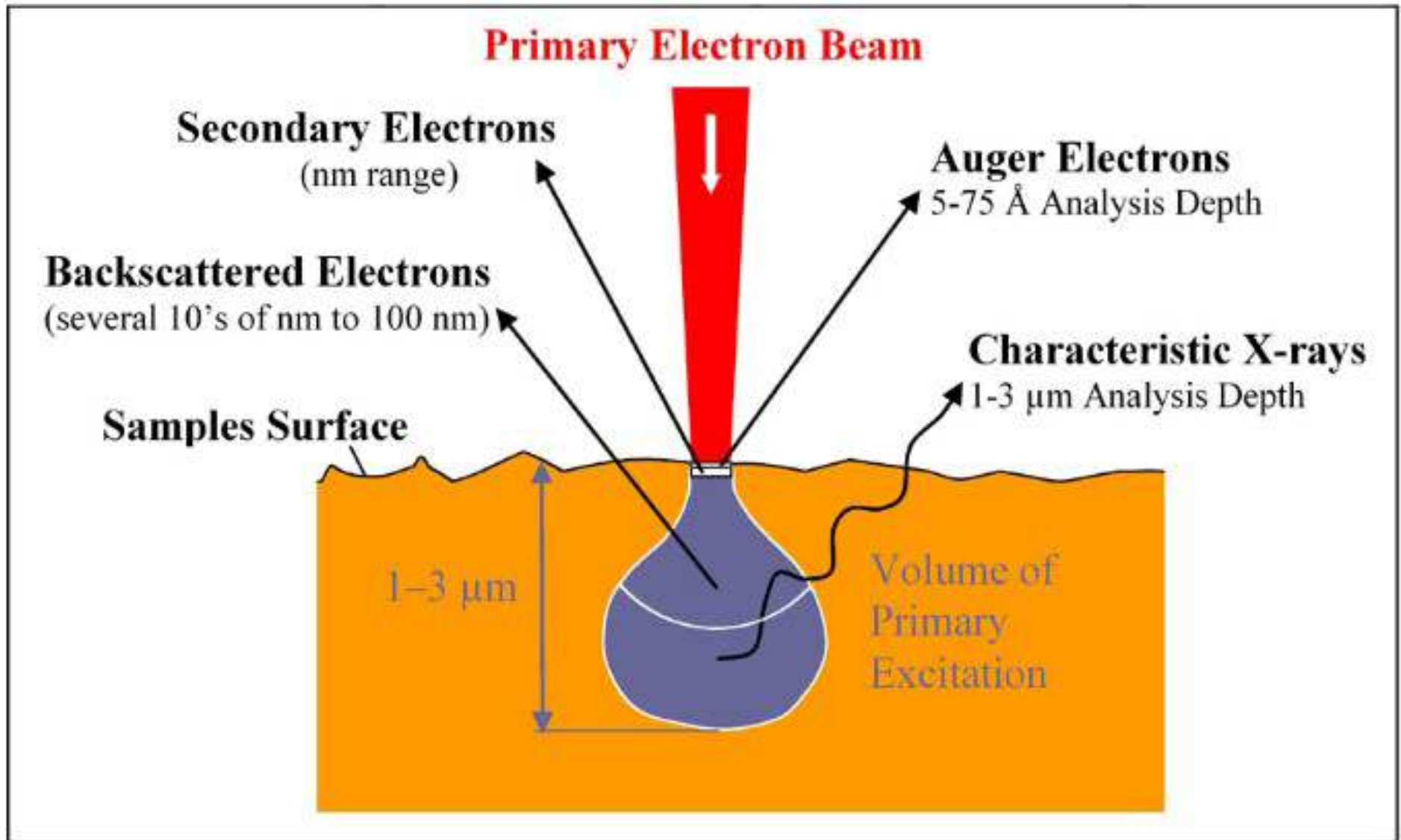
Linear Dichroism - Antiferromagnets



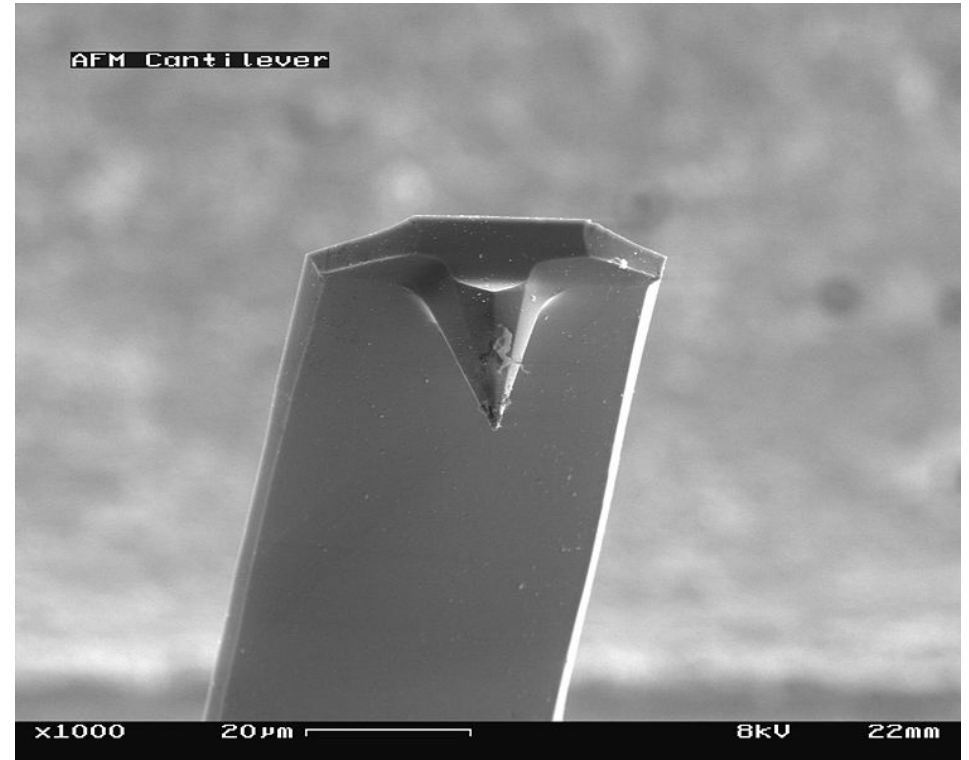
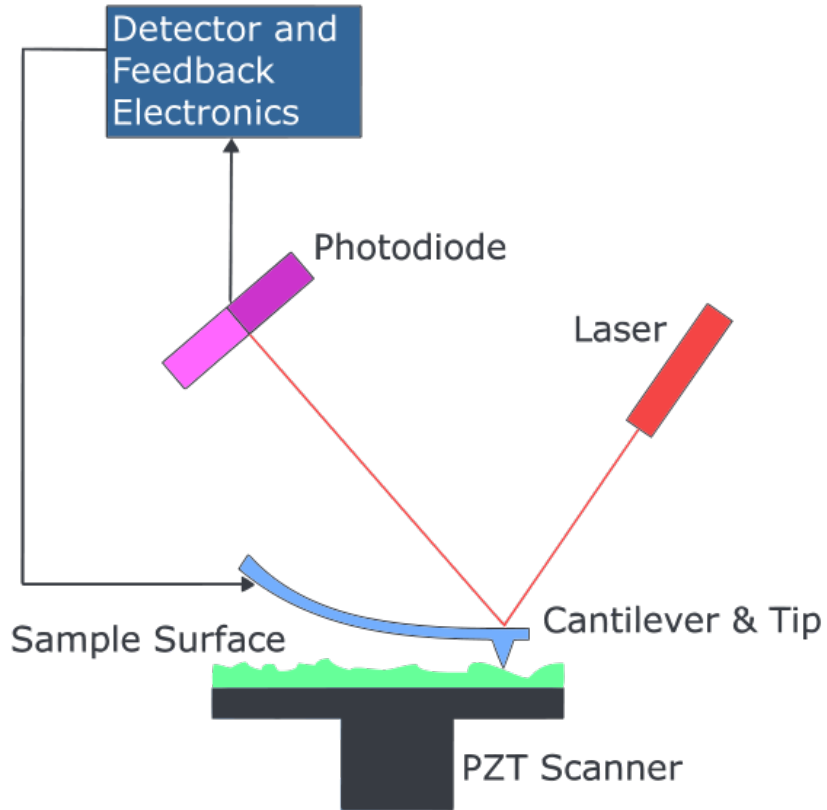
Circular Dichroism - Ferromagnets



Scanning electron microscopy



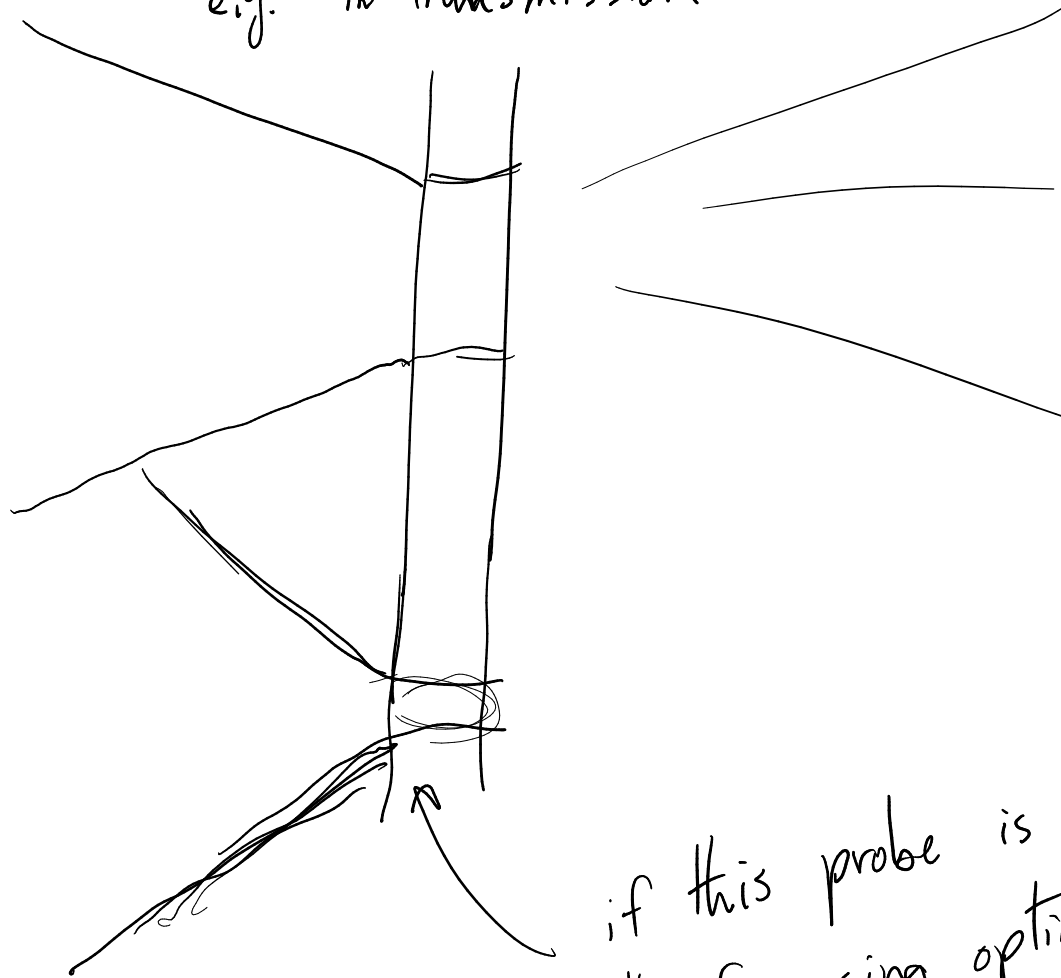
Atomic force microscopy



Resolution in scanning systems

Resolution mainly limited by probe size

e.g. in transmission



if this probe is formed
with focusing optics, then
PSF is again related
to numerical
aperture

Scanning vs. full field systems

Transmission probe: the reciprocity theorem

